Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/674,347	VAN DER WAL ET AL.
Examiner	Art Unit
Christine Ng	2616

SEARCHED					
Class	Subclass	Date	Examiner		
370	230.1	5/17/2006	CN		
370	232	5/17/2006	CN		
370	233	5/17/2006	CN		
370	234	5/17/2006	CN		
370	252	5/17/2006	CN		
370	253	5/17/2006	CN		
370	395.1	5/17/2006	CN		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SE. (INCLUDING	ARCH NOT	ES STRATEGY)
		DATE	EXMR
Huy Vu		5/17/2006	CN
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